N-Channel Enhancement Mode Power MOSFET

Description

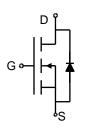
The JTM2N20PR uses advanced trench technology and design to provide excellent R_{DS(ON)} with low gate charge. It can be used in a wide variety of applications.

General Features

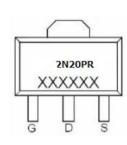
- $V_{DS} = 200V, I_{D} = 2A$ $R_{DS(ON)} < 580m\Omega @ V_{GS} = 10V (Typ:520m\Omega)$
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation

Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



Schematic diagram



SOT-89-3L

Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|----------|----------------|-----------|------------|----------|
| JTM2N20PR | JTM2N20P | SOT-89-3L | | - | - |

Absolute Maximum Ratings (T_A=25 ℃ unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|------------|------------|------|
| Drain-Source Voltage | VDS | 200 | V |
| Gate-Source Voltage | Vgs | ±20 | V |
| Drain Current-Continuous | I D | 2 | Α |
| Drain Current-Pulsed (Note 1) | Ірм | 8 | А |
| Maximum Power Dissipation | PD | 3 | W |
| Operating Junction and Storage Temperature Range | TJ, TSTG | -55 To 150 | °C |

Thermal Characteristic

| Thermal Resistance, Junction-to-Ambient (Note 2) | Reja | 41.7 | °C∕W |
|--|------|------|------|
|--|------|------|------|

Electrical Characteristics (T_A=25°Cunless otherwise noted)

| Parameter | Symbol | Condition | Min | Тур | Max | Unit |
|---------------------------------|--------|------------------|-----|-----|-----|------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BVoss | Vgs=0V Ip=250µA | 200 | - | - | V |
| Zero Gate Voltage Drain Current | Inss | Vps=200V, Vgs=0V | - | - | 1 | μA |

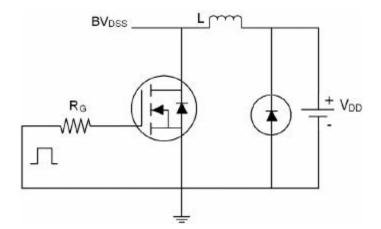
| Gate-Body Leakage Current | lgss | Vgs=±20V, Vps=0V | - | - | ±100 | nA |
|------------------------------------|-------------|---|----------|-----|------|----|
| On Characteristics (Note 3) | 1 | | | | | |
| Gate Threshold Voltage | VGS(th) | Vos=Vgs,lo=250µA | 2.5 | 3.4 | 4.5 | V |
| Drain-Source On-State Resistance | RDS(ON) | Vgs=10V, ID=2A | - | 520 | 580 | mΩ |
| Forward Transconductance | g FS | Vps=15V,lp=2A | - | 8 | - | S |
| Dynamic Characteristics (Note4) | • | | . | | | |
| Input Capacitance | Clss | Vps=25V, Vgs=0V, | - | 580 | - | PF |
| Output Capacitance | Coss | | - | 90 | - | PF |
| Reverse Transfer Capacitance | Crss | F=1.0MHz | - | 3 | - | PF |
| Switching Characteristics (Note 4) | 1 | | | | | |
| Turn-on Delay Time | td(on) | | - | 10 | - | nS |
| Turn-on Rise Time | tr | V _{DD} =100V, R _L =15Ω V _{GS} =10V,R _G =2.5Ω | - | 12 | - | nS |
| Turn-Off Delay Time | td(off) | | - | 15 | - | nS |
| Turn-Off Fall Time | tr | | - | 15 | - | nS |
| Total Gate Charge | Qg | Vbs=100V,lb=2A, | - | 12 | | nC |
| Gate-Source Charge | Qgs | VGS=10V | - | 2.5 | - | nC |
| Gate-Drain Charge | Qgd | VGS=10V | - | 3.8 | - | nC |
| Drain-Source Diode Characteristics | 1 | | · | | 1 | |
| Diode Forward Voltage (Note 3) | Vsp | Vgs=0V,ls=2A | - | - | 1.2 | V |
| Diode Forward Current (Note 2) | Is | | - | - | 2 | Α |

Notes:

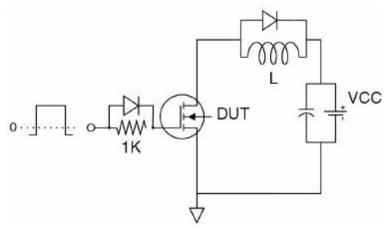
- $\textbf{1.} \ \ \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature}.$
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- $\textbf{4.} \ \ \textbf{Guaranteed by design, not subject to production}$

Test Circuit

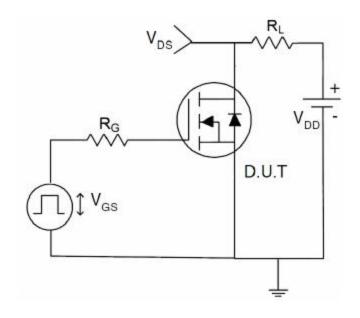
1) Eas test circuit



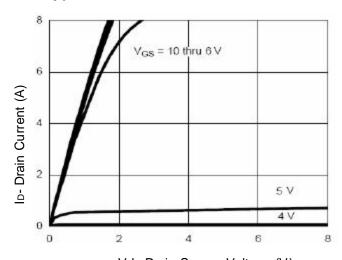
2) Gate charge test circuit



3) Switch Time Test Circuit

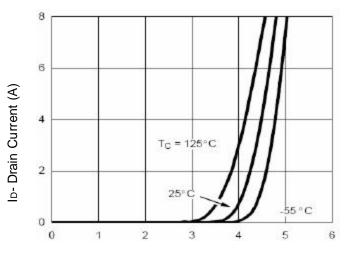


Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V)

Figure 1 Output Characteristics



Vgs Gate-Source Voltage (V)

Figure 2 Transfer Characteristics

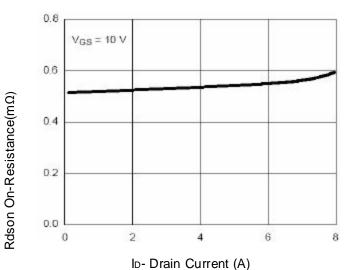


Figure 3 Rdson- Drain Current

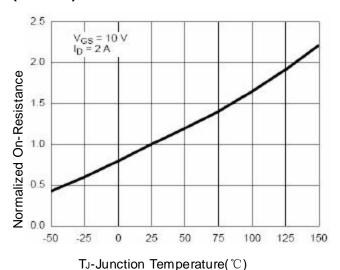


Figure 4 Rdson-JunctionTemperature

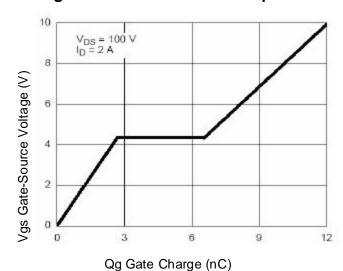


Figure 5 Gate Charge

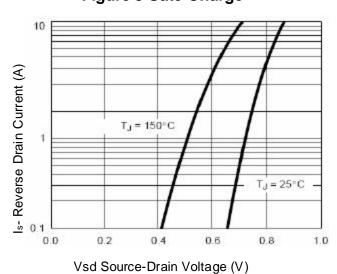


Figure 6 Source- Drain Diode Forward

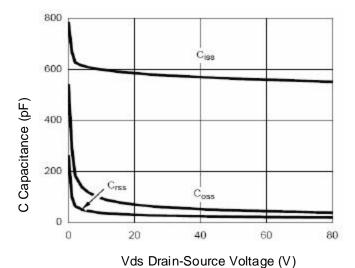


Figure 7 Capacitance vs Vds

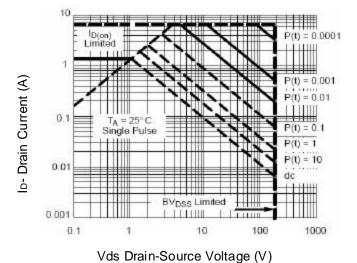
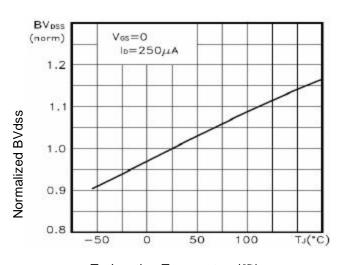
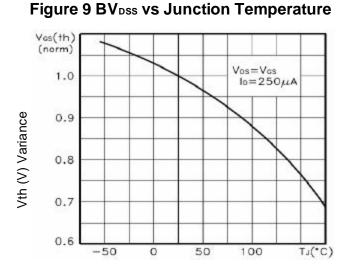


Figure 8 Safe Operation Area

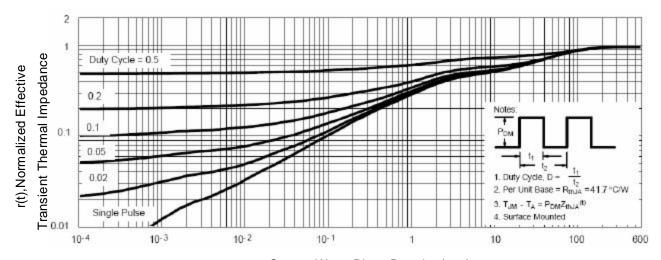


T_J-Junction Temperature($^{\circ}$ C)



T_J-Junction Temperature($^{\circ}$ C)





Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance

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